

### 650V, 120mΩ typ., GaN FET in DFN 8x8 Package

## 1. General Description

The KT65C1R120D is a 650V, 120 mΩ Gallium Nitride (GaN) FET in an 8 x 8 DFN package. It is a normally-off device that combines KeepTops's latest high-voltage GaN HEMT with a low voltage silicon MOSFET to offer superior reliability and performance.

## 2. Features and Benefits

- JEDEC-qualified GaN technology
- Dynamic  $R_{DS(on)eff}$  production tested
- Wide gate safety margin
- Capable of reverse conduction
- Low gate charge
- RoHS compliant and Halogen-free packaging
- Achieves increased efficiency in both hard- and soft- switched circuits
  - Increased power density
  - Reduced system size and weight
  - Overall lower system cost
- Easy to drive with commonly-used gate drivers

## 3. Applications

- Fast charger
- Telecom power
- Data center
- Lighting

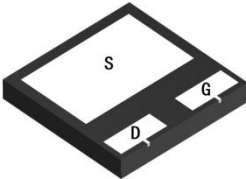
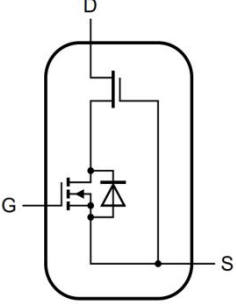
## 4. Key Specifications

Table 1. Key Specifications

Symbol	Parameter	Value	Unit
$V_{DS, max}$	Drain-source voltage	650	V
$I_D, max$	Continuous drain current @Tc = 25°C	17	A
$R_{DS(on), typ}$	Drain-source on-state resistance	120	mΩ
$Q_G, typ$	Total gate charge	16.2	nC
$Q_{RR, typ}$	Reverse recovered charge	84	nC

### 5. Pin Description

Table 2. Pin Description

Pin	Description	Bottom View	Graphic Symbol
G	Gate		
D	Drain		
S	Source		

### 6. Ordering Information

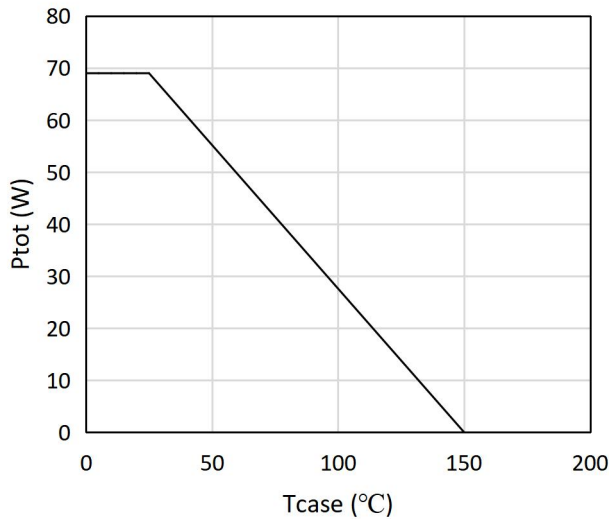
Table 3. Ordering Information

Part number	Package	Package Configuration	Marking Code
KT65C1R120D	DFN 8*8	Source	KT65C1R120D

### 7. Absolute Maximum Ratings

Table 4. Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Parameter	Symbol	Min.	Max.	Unit.	Conditions
Drain to source voltage	$V_{DSS}$	-	650	V	$V_{GS} = 0V$
Transient drain to source voltage	$V_{DSS(TR)}$	-	750		pulsed; $t_p \geq 1\mu s$ ; $D = 0.1$
Gate to source voltage	$V_{GSS}$	-20	20		
Maximum power dissipation	$P_D$	-	69	W	$T_C = 25^\circ C$ ; <a href="#">Fig.1</a>
Continuous drain current	$I_D$	-	17	A	$T_C = 25^\circ C$
		-	10	A	$T_C = 100^\circ C$
Pulsed drain current	$I_{DM}$	-	TBD	A	pulsed; $t_p \leq 200\mu s$ ; $T_C = 25^\circ C$
Operating temperature	$T_J$	-55	150	°C	
Storage temperature	$T_S$	-55	150	°C	



**Fig. 1. Power Dissipation**

TBD

**Fig 2. Safe Operating Area  $T_C = 25^\circ\text{C}$**

## 8. Thermal Characteristics

Table 5. Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Thermal resistance (Junction-to-case)	$R_{th(j-c)}$	-	1.8	-	$^\circ\text{C}/\text{W}$	
Thermal resistance (Junction-to-ambient) <sup>a</sup>	$R_{th(j-a)}$	-	50	-	$^\circ\text{C}/\text{W}$	
Reflow soldering temperature	$T_{SOLD}$	-	-	260	$^\circ\text{C}$	reflow MSL3

Notes:

- Device on one layer epoxy PCB for drain connection (vertical and without air stream cooling, with 6cm<sup>2</sup> copper area and 70μm thickness).

TBD

**Fig. 3. Transient Thermal Impedance**

## 9. Electrical Characteristics

Table 6. Electrical Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
<b>Forward Device Characteristics</b>						
Gate threshold voltage	$V_{GS(th)}$	-	4.3	-	V	$V_{DS} = V_{GS}$ ; $I_D = 0.5mA$ ; $T_J = 25^\circ C$
		-	TBD	-		$V_{DS} = V_{GS}$ ; $I_D = 0.5mA$ ; $T_J = 150^\circ C$
Drain-source on-state resistance <sup>a</sup>	$R_{DS(on)}$	-	120	-	mΩ	$V_{GS} = 12V$ ; $I_D = 6A$ ; $T_J = 25^\circ C$ ; <a href="#">Fig.18</a> ; <a href="#">Fig.19</a>
		-	240	-		$V_{GS} = 12V$ ; $I_D = 6A$ ; $T_J = 150^\circ C$ ; <a href="#">Fig.18</a> ; <a href="#">Fig.19</a>
Drain-to-source leakage current	$I_{DSS}$	-	8.4	-	μA	$V_{DS} = 650V$ ; $V_{GS} = 0V$ ; $T_J = 25^\circ C$
		-	TBD	-		$V_{DS} = 650V$ ; $V_{GS} = 0V$ ; $T_J = 150^\circ C$
Gate-to-source leakage current	$I_{GSS}$	-	-	100	nA	$V_{GS} = 20V$ ; $V_{DS} = 0V$ ; $T_J = 25^\circ C$
		-	-	-100		$V_{GS} = -20V$ ; $V_{DS} = 0V$ ; $T_J = 25^\circ C$

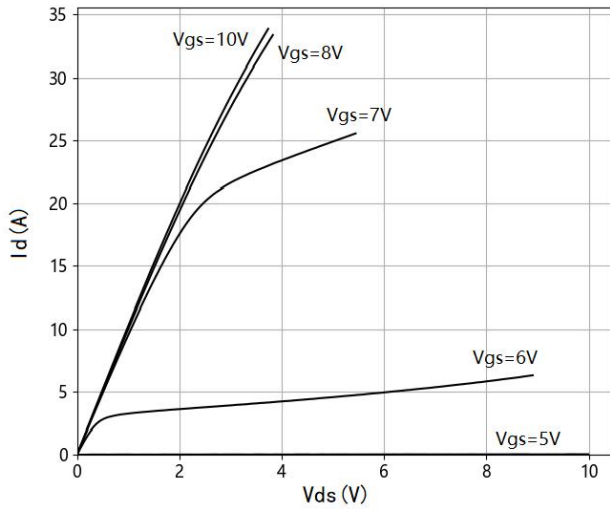
Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Input capacitance	$C_{ISS}$	-	703	-	pF	$V_{GS} = 0V$ ; $V_{DS} = 400V$ ; $f = 1MHz$ ; <a href="#">Fig.8</a>
Output capacitance	$C_{OSS}$	-	79	-		
Reverse transfer capacitance	$C_{RSS}$	-	2	-		
Output capacitance, energy related <sup>b</sup>	$C_{O(er)}$	-	104	-	pF	$V_{GS} = 0V$ ; $V_{DS} = 0V$ to 400V; <a href="#">Fig. 9</a>
Output capacitance, time related <sup>c</sup>	$C_{O(tr)}$	-	201	-		
Total gate charge	$Q_G$	-	16.2	-	nC	$V_{DS} = 400V$ ; $V_{GS} = 0V$ to 12V; $I_D = 10A$ ; <a href="#">Fig. 11</a>
Gate-source charge	$Q_{GS}$	-	5.6	-		
Gate-drain charge	$Q_{GD}$	-	7.2	-		
Output charge	$Q_{OSS}$	-	80.5	-	nC	$V_{GS} = 0V$ ; $V_{DS} = 0V$ to 400V
Turn-on delay	$t_{D(on)}$	-	61.6	-	ns	$V_{DS} = 400V$ ; $V_{GS} = 0V$ to 12V; $I_D = 4A$ ; $R_G = 30\Omega$ ; <a href="#">Fig.14</a> ; <a href="#">Fig.15</a>
Rise time	$t_R$	-	9	-		
Turn-off delay	$t_{D(off)}$	-	58.7	-		
Fall time	$t_F$	-	7.9	-		

Reverse Device Characteristics						
Reverse voltage	$V_{SD}$	-	1.7	-	V	$V_{GS} = 0V; I_S = 10A; T_J = 25^\circ C;$ <a href="#">Fig. 12</a>
		-	2.2	-		$V_{GS} = 0V; I_S = 10A; T_J = 150^\circ C;$ <a href="#">Fig. 12</a>
Reverse recovery time	$t_{RR}$	-	17	-	ns	$V_{DD} = 400V;$ $di/dt = 1000A/\mu s;$ $V_{GS} = 0V; I_S = 10A; T_J = 25^\circ C;$
Reverse recovery charge	$Q_{RR}$	-	84	-	nC	<a href="#">Fig. 16; Fig. 17</a>

Notes:

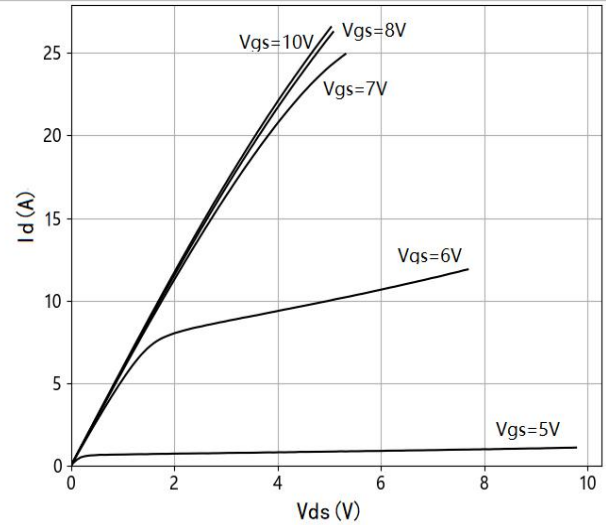
- Dynamic  $R_{DS(on)}$  value
- Equivalent capacitance to give same stored energy from 0V to 400V
- Equivalent capacitance to give same charging time from 0V to 400V

## 9.1 Electrical characteristics (curves) ( $T_C=25^\circ\text{C}$ unless otherwise stated)



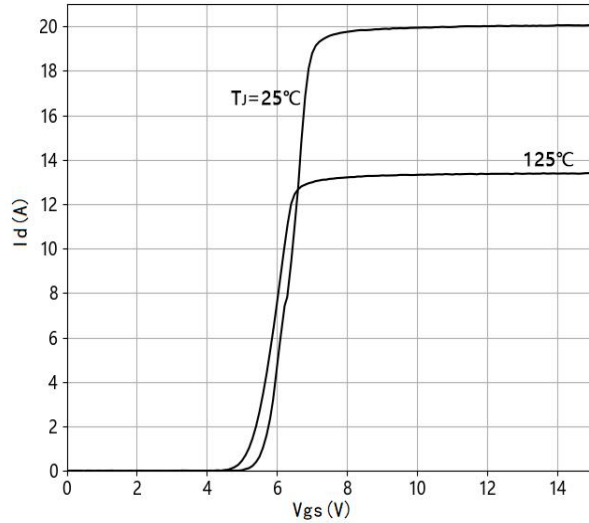
**Figure 4. Typical Output Characteristics**

$T_J = 25^\circ\text{C}$



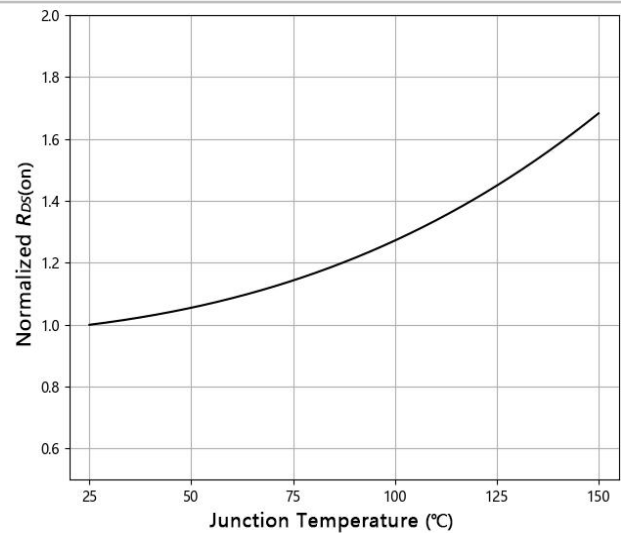
**Figure 5. Typical Output Characteristics**

$T_J = 150^\circ\text{C}$



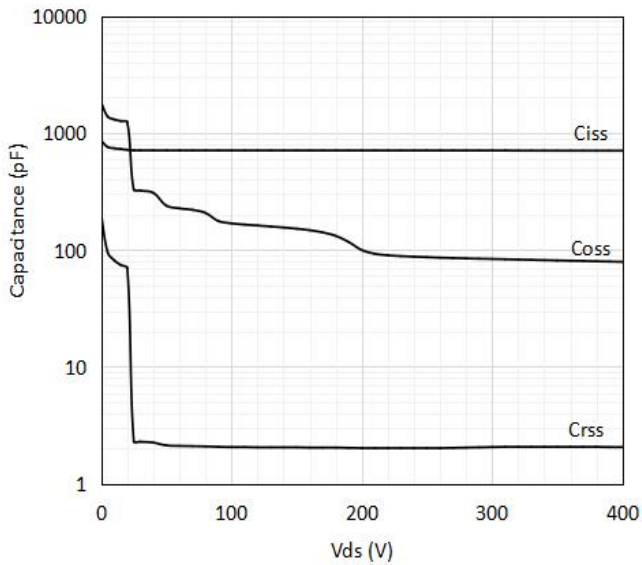
**Fig. 6. Typical Transfer Characteristics**

$V_{DS} = 2\text{V}$



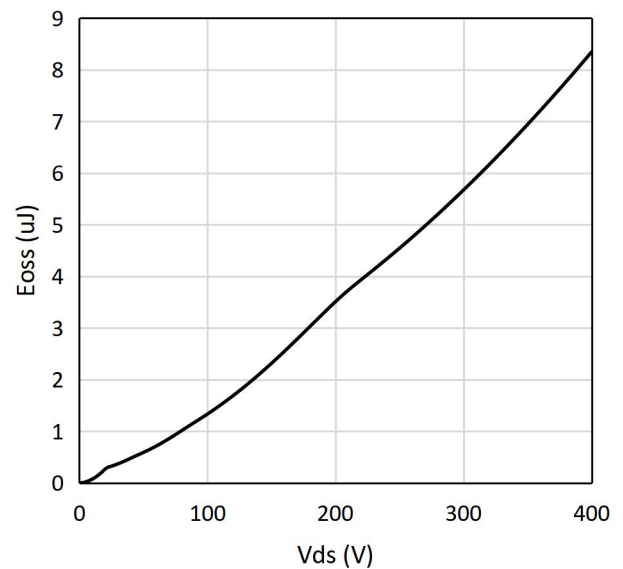
**Fig. 7. Normalized On-resistance**

$I_D = 4\text{A}, V_{GS} = 12\text{V}$



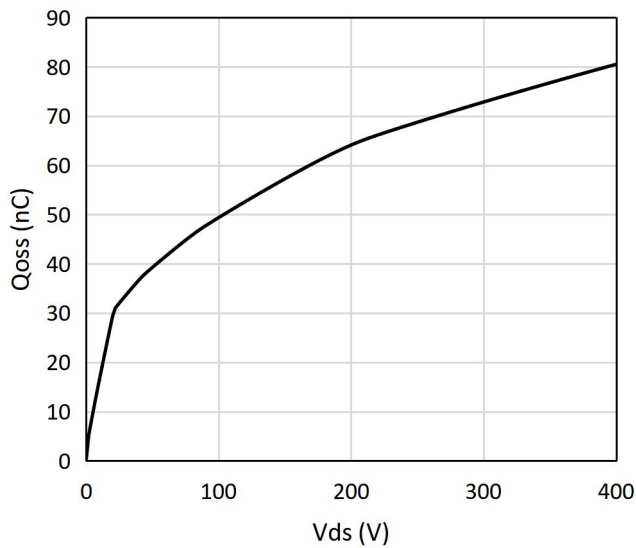
**Fig. 8. Typical Capacitance**

$V_{GS} = 0V, f = 1MHz$



**Fig. 9. Typical Coss Stored Energy**

$V_{GS} = 0V, f = 1MHz$

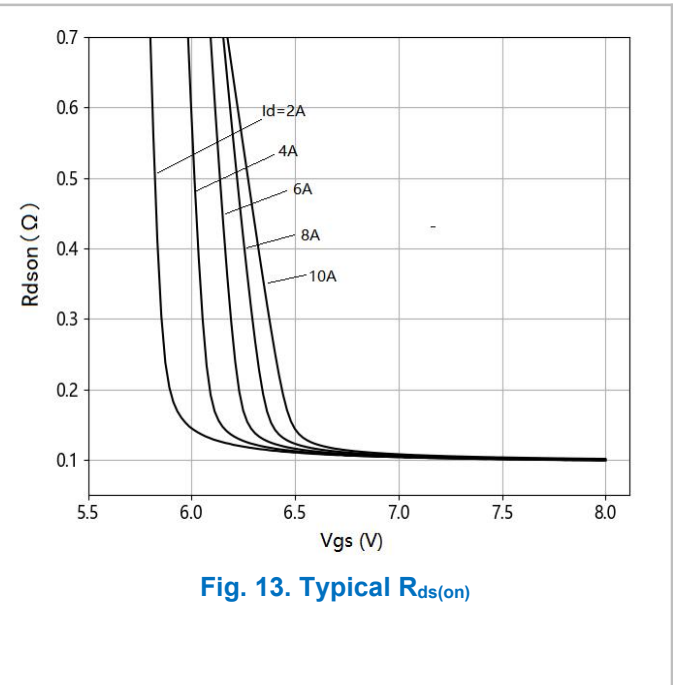
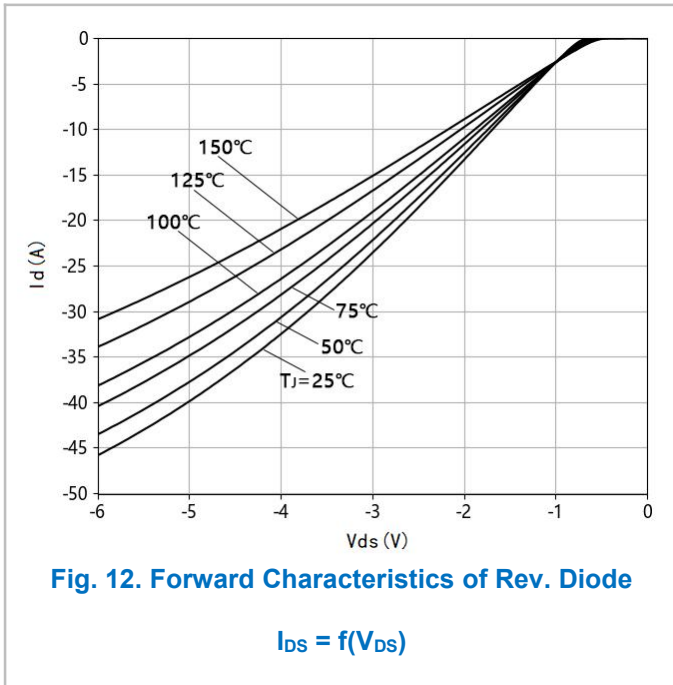


**Fig. 10. Typical Qoss**

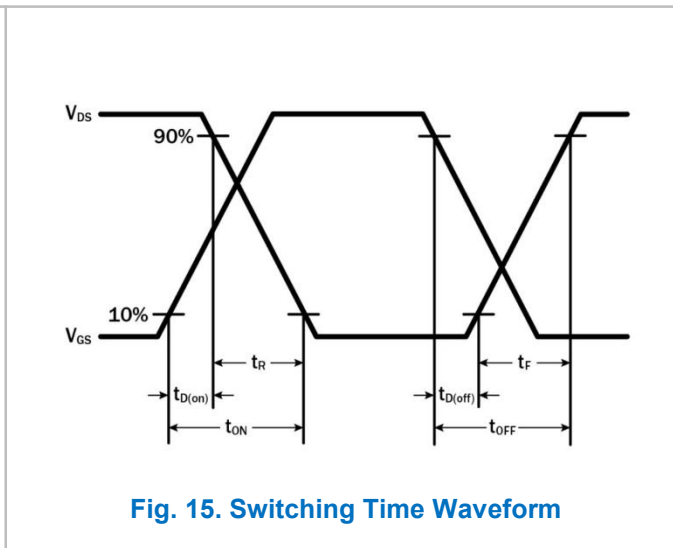
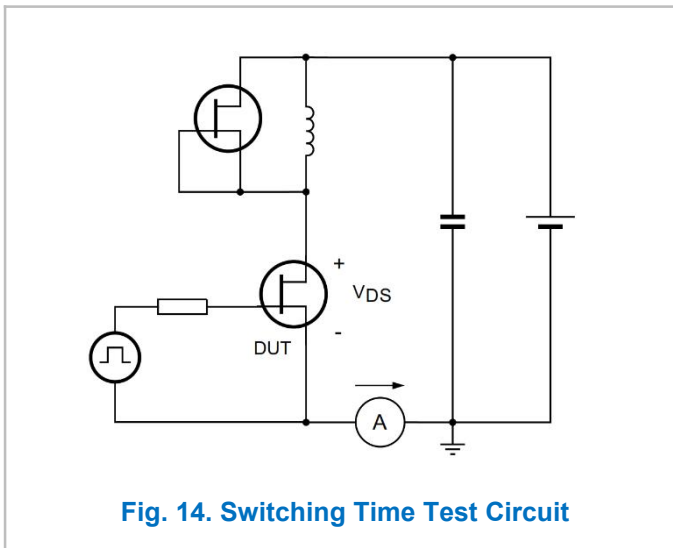
TBD

**Fig. 11. Typical Gate Charge**

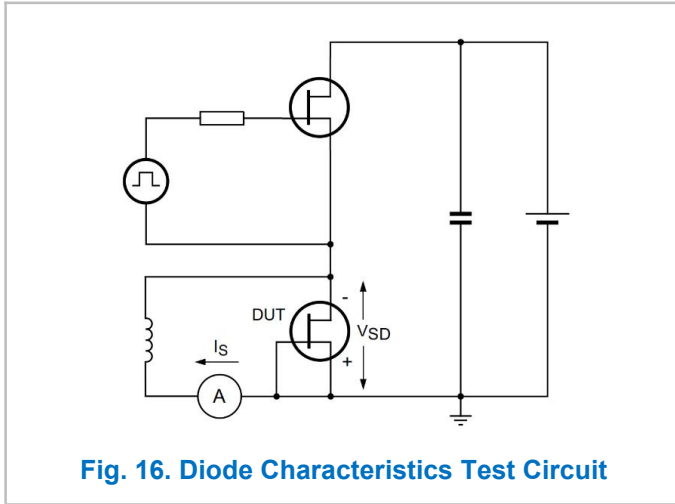
$I_D = 10A, V_{DS} = 400V$



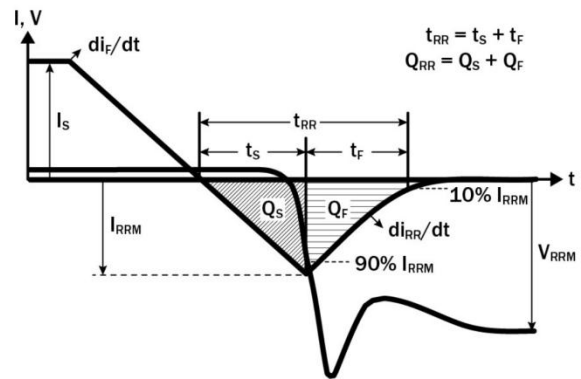
## 10. Test Circuits



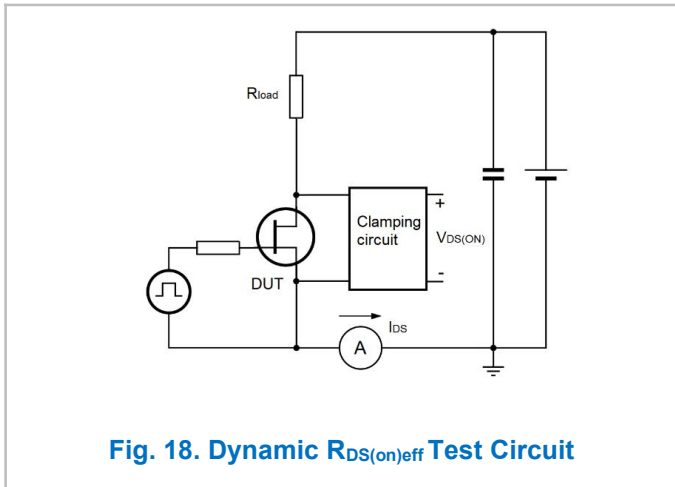




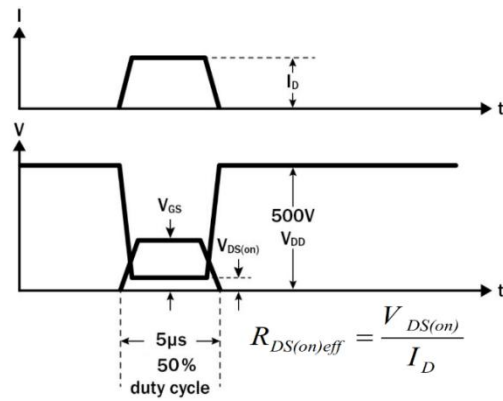
**Fig. 16. Diode Characteristics Test Circuit**



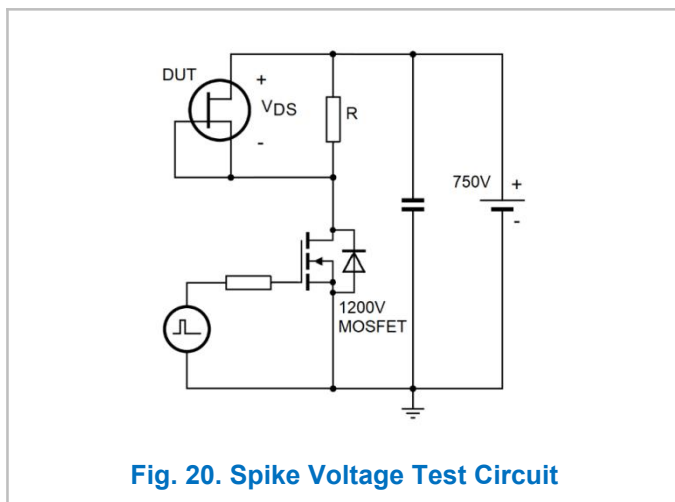
**Fig. 17. Diode Recovery Waveform**



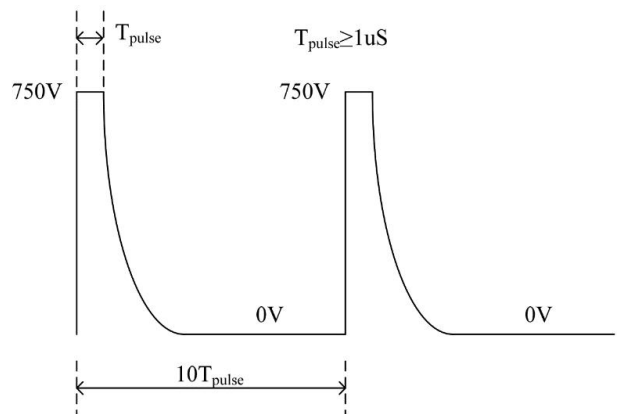
**Fig. 18. Dynamic  $R_{DS(on)eff}$  Test Circuit**



**Fig. 19. Dynamic  $R_{DS(on)eff}$  Waveform**



**Fig. 20. Spike Voltage Test Circuit**



**Fig. 21. Spike Voltage Waveform**

### 11. Package Information

#### 11.1 DFN 8x8 Package Information

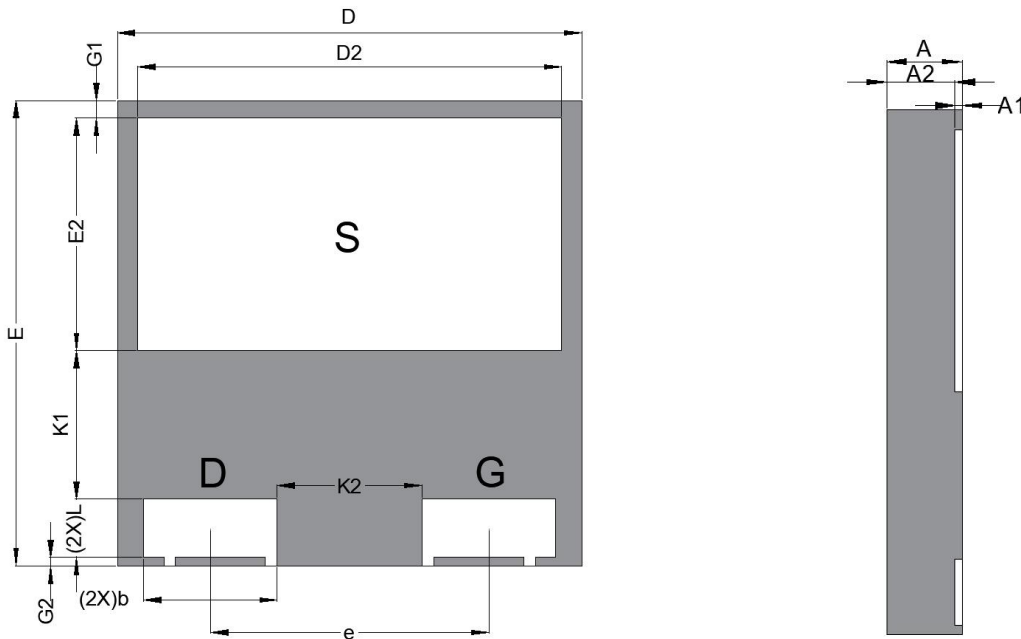


Fig. 22. DFN 8x8 Package Outline

DIM	mm			in		
	MIN	NOM	MAX	MIN	NOM	MAX
A	1.35	1.40	1.45	0.053	0.055	0.057
A1	0.007	0.012	0.017	/		
A2	1.362	1.412	1.462	/		
b	2.25	2.30	2.35	0.088	0.090	0.092
D	7.90	8.00	8.10	0.308	0.312	0.316
D2	7.25	7.30	7.35	0.283	0.285	0.287
E	7.90	8.00	8.10	0.308	0.312	0.316
E2	4.20	4.25	4.30	0.164	0.166	0.168
e	4.8BSC			0.187BSC		
K1	2.50	-	-	0.098	-	-
K2	2.50	-	-	0.098	-	-
L	0.75	0.80	0.85	0.029	0.031	0.033
G1	0.25	0.30	0.35	0.010	0.012	0.014
G2	0.10	0.15	0.20	0.004	0.006	0.008

## 12. Important Notice

KeepTops reserves the right to modify or enhance the products and/or specifications described herein at any time and at KeepTops's sole discretion. All information in this document, including descriptions of product features and performance, is subject to change without notice. Purchasers should obtain the latest relevant information on KeepTops's products before placing orders. Performance specifications and the operating parameters given in this document shall in no event be regarded as a guarantee of conditions or characteristics. The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

## Revision History

Revision	Date	Changes
1.0	2022/10/9	Release Preliminary Datasheet